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Synthesis of high quality two-dimensional materials via chemical vapor deposition

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Two-dimensional (2D) materials have attracted much attention due to their unique properties and great potential in various applications. Controllable synthesis of 2D materials with high quality and high efficiency is essential for their large scale applications. Chemical vapor deposition (CVD) has been one of the most important and reliable techniques for the synthesis of 2D materials. In this perspective, the recent advances in the CVD growth of three typical types of two-dimensional materials, graphene, boron nitride and transition metal dichalcogenides (TMDs), are briefly introduced. Large area preparation, single crystal growth and some mechanistic insight are discussed with details. Finally we give a brief comment on the challenges of CVD growth of 2D materials.

Introduction

Chemical vapor deposition (CVD) is a time-honored technique that dates back to centuries ago. The first industrial application of the CVD technique can be traced back to 1897 when de Lodyguine¹ reduced tungsten hexachloride using hydrogen to deposit tungsten onto the carbon filament of lamps. CVD was then developed as a reliable extraction method to produce highly purified materials such as Ti, Ta, Zr and Si. For example, the Siemens method and its modifications² are currently applied in the mass production of high-purity polycrystalline silicon, which is vital for the final production of single crystal silicon. Despite the massive application of CVD, it is only in the past half century that the in-depth insight into the process has

been achieved.³ CVD has already been recognized as a reliable synthetic method for zero-dimensional nanomaterials (quantum dots and nanocrystals) and one-dimensional nanomaterials (nanowires and nanotubes, *etc.*).

Two-dimensional (2D) materials have attracted much attention due to their unique properties and great potential in various applications. Controllable synthesis of two-dimensional materials with high quality and high efficiency is essential for their large scale applications. The methods for synthesis of two-dimensional materials mainly include mechanical exfoliation, liquid phase routes, and CVD. Mechanical exfoliation of bulk materials is able to acquire final products of the highest quality with very limited efficiency. Liquid phase reactions, such as chemical exfoliation and hydrothermal or solvothermal reactions, have high efficiency but the size of the sheets is usually small and the quality of the product is relatively low and difficult to control compared with mechanical exfoliations. CVD, on the other hand, offers a compromise between quality, efficiency,

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consistency, and control over the process. The efficiency is much higher than for mechanical exfoliation, and the quality control is better than liquid phase routes. Therefore CVD has been recognized as a reliable route for preparing high quality two-dimensional (2D) materials recently.

Typically, CVD growth of 2D materials involves activated chemical reactions of precursors in a specially-designed environment. The precursors, conditions, atmospheres, substrates and catalysts (if necessary) are several key factors affecting the final quality of the 2D materials. Much progress has been made in preparing 2D materials by CVD and many challenges must be addressed. Herein, we briefly review the CVD growth of several signature layered two-dimensional materials such as graphene, BN, and transition metal dichalcogenides (TMDs), focusing mainly on the precursors, conditions, substrates and end products. The advances in the preparation of large area and single crystal two-dimensional materials are introduced briefly with some discussion of the mechanism, and only a small part of the excellent work to date is included due to the limited space.

CVD growth of graphene

Ever since the first discovery in 2004 and being the subject of the Nobel Prize in physics in 2010,⁴ graphene has been a point of interest for the scientific community. The first graphene sample was prepared *via* exfoliation using Scotch tape, which exhibited limited efficiency despite being of the highest quality of all samples made from all the available methods. Other methods have been developed to synthesize graphene in order to improve the efficiency, such as liquid-phase exfoliation, reduction of graphene oxides and bottom-up methods

including chemical vapor deposition. Due to the single-atomic thickness of graphene films, the growth of graphene *via* CVD needs delicate control of the CVD process.

As suggested by theoretical modeling analysis and indicated by the experimental results, the mechanism of the catalyzed CVD growth of graphene is similar to the early stage of the catalyzed CVD growth of carbon nanotubes.^{5,6} The catalyst, however, is in the shape of a film for graphene rather than grains or droplets for carbon nanotubes. With additional manipulation of the reaction parameters, graphene synthesis is favored over that of carbon nanotubes. Transition metals (Cu and Ni),^{7,8} rare-earth metals (Ru),⁹ noble metals (Pt)¹⁰ and other metals or even compounds have been reported as catalysts for the CVD growth of graphene. Transition metals are believed to be the most efficient catalysts, especially after pre-reaction modification or with certain crystal orientations, and are relatively cheap compared with noble and rare-earth metals.¹¹ Transition metals can work as both synthesizing substrates and catalysts, and are easily removed to obtain free-standing graphene without compromising the integrity of the grown graphene. It should be noted that the CVD growth mechanisms of graphene with Cu and Ni as catalysts are different. Carbon isotope labeling confirmed that the CVD growth of graphene with a Cu catalyst is a surface adsorption process, while the CVD growth of graphene with a Ni catalyst is a diffusion followed by segregation and precipitation process of C on the Ni surface.¹²

Polycrystalline graphene by CVD

The earliest reports on CVD synthesized thin graphite materials are from the 1970s in the early days of investigation into the CVD process.^{13–15} However, the first successful synthesis of



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few-layer graphene films of about 30 layers *via* CVD was reported by Somani *et al.* with nickel foils as substrates and camphor as a gaseous reactant (Fig. 1a).⁸ This work demonstrated the plausibility of the CVD growth of layered graphene films, but there is much room for further reducing the thickness. Following this work, many efforts have been made to optimize the CVD growth of graphene films, focusing on precursors, substrates, catalysts, temperatures and atmospheres. Reina *et al.* managed to reduce the thickness of CVD synthesized graphene to the few-layer level.¹⁶ 500 nm Ni film was evaporated onto SiO₂/Si substrates as a catalyst. After reductive annealing, few-layer graphene was deposited onto the substrates at 900–1000 °C with 5–25 sccm methane and 1500 sccm hydrogen as the gas flow at atmospheric pressure. The synthesized graphene consisted of 1–12 layers with single or double layer regions of up to 20 μm. The prepared graphene film could withstand multiple processing steps without compromising the structural integrity. In another work, Pollard *et al.* demonstrated CVD growth of single-layer graphene on a Ni thin film evaporated on SiO₂/Si substrates.¹⁷ The Ni film was deposited onto SiO₂ (300 nm in thickness)/Si(100) substrates by sublimation under 10⁻⁴–10⁻⁵ Pa. Freestanding single-layer graphene films were obtained by etching off the Ni film.

One of the most important advances in the CVD growth of single layer graphene was reported in 2009. Li *et al.* prepared large-area graphene films *via* CVD on copper foils,¹⁸ and the grown graphene films were mostly of single-layer thickness, with less than 5% double or triple layers (Fig. 1b). Methane and hydrogen were applied as gas sources in this work, and copper

foil substrates were sequentially removed by treatment with iron nitrite solution to obtain free-standing graphene films. The chemical etching process to remove the substrates became widely applied, since it took advantage of the chemical stability of graphene which avoided defects induced by micro-mechanical exfoliation and enabled easy transfer to dedicated substrates or films for heterostructure construction. To obtain uniform monolayer large area graphene, it is useful to selectively remove the bi-/tri- layer graphene. Fang *et al.* demonstrated that bi-/tri-layer graphene was selectively removed by the carbon-absorbing W foil enclosed in Cu foil while the monolayer graphene remained intact.¹⁹

Compared to single-layer graphene, bilayer graphene has a tunable bandgap which could benefit many electronic and optical device applications.²⁰ Lee *et al.* prepared wafer-scale bilayer graphene using CVD with methane.²¹ The key factor in this work was to control the cooling rate down to approximately 18 K min⁻¹. The bilayer coverage was 99%, and the method was easy to scale up. Another route to synthesize bilayer graphene is through the epitaxial growth of one layer graphene onto another layer. Yan *et al.* demonstrated a layer-by-layer vapor phase epitaxial synthesis of bilayer graphene.²² A second layer of graphene was grown on copper foil which was already deposited with a layer of graphene. However, only 67% coverage of bilayer graphene was achieved and more efforts are needed.

Besides single or bilayer graphene, it is also important to gain control over the number of layers in CVD grown graphene. Gong *et al.* controlled the number of layers of CVD graphene to within 1–10 layers mainly by controlling the flow of hydrogen, the thickness of the deposited nickel catalyst, and the growth temperature and time.²³ But to obtain uniform graphene with a consistent number of layers is still challenging. In another work, by delicately controlling the parameters including temperature, deposition time, overall gas flow and pressure, control over the layers of CVD grown graphene was realized. Tu *et al.* took the control one step further with an accuracy of down to one single layer within 7 layers.²⁴

For the catalyzed CVD growth of graphene, complicated transfer from metal to working substrates is needed. Therefore, many efforts have been made to deposit graphene films onto the real working substrates without any catalysts. Shang *et al.* applied microwave-assisted plasma chemical vapor deposition (MPCVD) to grow multi-layered graphene on silicon substrates.²⁵ Hwang *et al.* synthesized single layer graphene on sapphire substrates *via* van der Waals epitaxy using CVD.²⁶ Although the deposition temperature was around 1400 °C, p-type and n-type single-layer graphene could be obtained by altering the partial pressure of methane gas. Wang *et al.* showed a slightly different method and single layer graphene films were synthesized *via* CVD on h-BN films grown using CVD on copper foils.²⁷ Chen *et al.* demonstrated catalyst-free CVD growth of single crystal graphene on various dielectric substrates, such as Si₃N₄/SiO₂/Si and sapphire.²⁸ The CVD growth was near-equilibrium, resulting in single crystal graphene sheets with a quality close to that of metal-catalyzed sheets but with a small sheet size of only 11 μm.

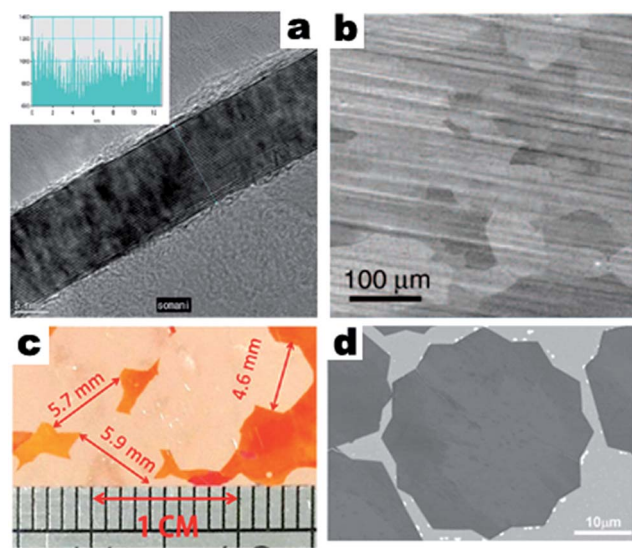


Fig. 1 (a) TEM image and intensity pattern along the marked line (inset) of a CVD synthesized graphene film, reprinted from ref. 8 by permission of Elsevier; (b) SEM image of a CVD synthesized single layer graphene film, reprinted from ref. 18 by permission of American Association for the Advancement of Science; (c) optical image of CVD synthesized single graphene sheets on copper foil, reprinted from ref. 36 by permission of American Chemical Society; (d) SEM images of CVD synthesized single crystal twelve point graphene grains on melted copper, reprinted from ref. 43 by permission of John Wiley & Sons.



Single crystal graphene by CVD

Most of the CVD synthesized graphene is polycrystalline graphene which shows a much inferior performance compared to that exfoliated from bulk graphite. It is believed that the grain boundaries in polycrystalline graphene are the main cause for the inferiority. Thus, many efforts have been devoted to the controllable and high-quality synthesis of single crystal graphene. The common approach is to modify the substrates/catalyst films, typically by annealing under a hydrogen atmosphere at a higher temperature, to promote grain growth and suppress normal CVD growth. Larger grains will induce fewer grain boundaries and thus enhanced performances. Applying single crystal substrates/catalyst films in the CVD growth of graphene would produce single crystal graphene,²⁹ although the commercially-available single crystal substrates/catalyst films are too expensive for wide application.

Recently, CVD growth of single crystal graphene was successfully executed on commercial transition metal substrates like copper foils. Vlassiok *et al.*⁷ grew large single crystal graphene *via* a CVD process under an atmosphere of hydrogen, methane and argon with copper foils as substrates and catalysts, and hydrogen as a cocatalyst. By altering the partial pressure of hydrogen and methane, well-defined perfect single crystal graphene was obtained. The size of the obtained graphene was around 10 μm , and the graphene showed weak binding to the copper foil substrates, which benefitted sequential removal of the substrates and the fabrication of prototype devices. In another work, Wu *et al.*³⁰ managed to increase the efficiency of single crystal graphene on copper foils made *via* the CVD method by employing PMMA dot arrays onto the copper foils. The PMMA patterns were sequentially spin-coated, cured and annealed prior to a high temperature CVD process under an atmosphere of argon, methane and hydrogen. By employing additional PMMA coating after the CVD process, the arrangement of the graphene grains was successfully kept uncompromised during the removal of the copper foils and the transfer process. The size of the graphene grains was also around 10 μm . Similarly, under atmospheric pressure, Robertson³¹ and Warner synthesized hexagonal single crystal graphene domains *via* CVD with copper as the substrate and hydrogen as the co-catalyst. The obtained graphene was single crystal few layer graphene.

Besides the efficiency, increasing the size of the grown graphene sheets is also a point of interest. Li *et al.*³² further improved the above-mentioned technical routes one step further. With low pressure and an extended growth time for the CVD process, Li *et al.* obtained graphene grains as large as 0.5 mm. Copper enclosures were used as substrates, offering a large deposition site for graphene. Wang *et al.*³³ also prepared single crystal graphene sheets with sub-millimeter size *via* an atmospheric pressure CVD (APCVD) process. Chen *et al.* suppressed the evaporation loss of copper during the CVD growth of single crystal graphene, and obtained graphene sheets with sizes up to 2 mm.³⁴ In their work, the CVD process was operated under low pressure, and if the deposition process lasted long enough, the

copper substrate could suffer from evaporative loss during the deposition due to the high deposition temperature. Controlling chamber pressure can lead to single crystal CVD growth. Yan *et al.*³⁵ obtained single crystal graphene sheets with a size of 2.3 mm *via* a controlled chamber pressure CVD process. The chamber pressures of the substrate and catalyst pre-deposition treatment, deposition and cooling procedure were all modified. Besides controlling the chamber pressure, manipulating the carbon source could also trigger the growth of large size single crystal graphene. Gan *et al.*³⁶ prepared even bigger single crystal graphene sheets by delicately controlling the hydrogen flow throughout the process. The crucial step was to anneal the copper substrates under an Ar atmosphere before the reductive pre-deposition treatment under an Ar/H₂ atmosphere. The annealing induced mild oxidation, which provided unique nucleation sites or seeds for the CVD growth of single crystal graphene. With a prolonged deposition time, single crystal graphene sheets with sizes up to 5.9 mm were obtained (Fig. 1c). Zhou *et al.* also demonstrated similar results.³⁷ They systematically studied argon atmosphere annealing before reductive heat treatment, low chamber pressure and high hydrogen/methane molar ratios of over 1000, and showed significantly reduced nucleation density in the CVD process. The size of the resulting single crystal single-layer graphene sheets was 5 mm, and the size of the resulting single crystal double-layer graphene sheets was 300 μm . These works were all carried out on metal substrates. However, Lee *et al.* prepared wafer-scale monolayer single crystal graphene on epitaxial Ge films on silicon wafers as a substrate.³⁸ The single crystal monolayer graphene could reach a wafer size of 2 inches.

The carbon precursor applied in the above-mentioned works is gaseous methane, but it is not the only option. Wu *et al.* demonstrated that, by heating polystyrene with a halon lamp, the carbon source feedstock could easily be manipulated. Even with an atmospheric pressure CVD process, single crystal graphene with sizes up to 1.2 mm could be synthesized.³⁹ This work not only demonstrated the plausibility of modifying the carbon source feedstock to obtain large single crystal graphene, but also revealed a new type of precursor other than gaseous methane. Xue *et al.*⁴⁰ also reported the CVD growth of single crystal graphene with pyridine as a precursor, which lead to nitrogen doping during the synthesis. These kinds of CVD growth methods with non-gaseous precursors have the advantage of a significantly lower deposition temperature, but high-temperature pre-deposition treatments of substrates/catalysts are still necessary. Meanwhile, a direct indication and a precise control of the precursor flow is difficult to come by. Therefore, gaseous precursors like methane are still the most applied carbon sources in the synthesis of single crystal graphene using CVD.

Most CVD processes need to be carried out at a temperature below the melting point of copper. However, several works have used a CVD reaction temperature above the melting point of copper, which would favor the growth of relatively large sheets of single crystal graphene. Wu *et al.*⁴¹ raised the deposition temperature to above the melting point of copper, and with Mo foils that could be wetted by copper as the substrates and melted copper as the catalyst, sub-millimeter size single crystal



graphene sheets were obtained *via* atmospheric pressure CVD. Geng *et al.* demonstrated the CVD growth of smaller but denser single crystal graphene flakes. In their work, control over the size and efficiency of single crystal graphene flakes was gained by controlling the temperature and partial pressure of the methane gas flow.⁴² Geng *et al.* demonstrated the controlled CVD growth of twelve pointed graphene grains (TPGGs) on a melted copper film with tungsten foils underneath as substrates (Fig. 1d).⁴³ The as-synthesized TPGG was a single crystal, and the morphology was controlled by altering the carbon feedstock. Melting and resolidifying the substrates prior to CVD growth would achieve a similar effect as keeping the substrates molten. Mohsin *et al.* melted and resolidified copper film on tungsten substrates by sequentially raising and reducing the temperature to obtain a smooth surface and minimal surface irregularities.⁴⁴ The nucleation density was significantly reduced and the CVD growth of graphene on this type of copper under a high reaction temperature produced millimeter sized single crystal graphene flakes with well defined hexagonal shapes. The reductive treatment of copper was still necessary to suppress other irregularities in the copper catalyst.

Most single crystal graphene synthesized *via* CVD is single layer, especially those of a large size. CVD growth of large few-layer single crystal graphene is still a challenge. Yan *et al.* demonstrated the CVD growth of double and triple layer graphene single crystals, in which the interlayer rotation within graphene single crystals was induced by graphene nucleation steps on the copper foils during the synthesis.⁴⁵ The pre CVD treatments were prolonged to 7 hours in order to achieve the required copper surfaces. In Table 1, we summarize the substrates, catalysts, overall gas flows, temperatures, pressures and corresponding product qualities of graphene for some typical CVD growth processes.

Mechanistic insight into the CVD growth of single crystal graphene

CVD growth of single and polycrystalline graphene are two procedures that are similar in many aspects (Fig. 2a).³⁵ However, there are several key factors that distinguish the CVD growth of single crystal graphene.⁴⁶ First, the suppression of nucleation allows space for the growth of single crystal graphene. The pre-deposition, reductive treatment of typical substrates (copper) eliminates impurities, oxides, sharp wrinkles, defects and other structures of the substrates that could favor the nucleation of graphene. Second, by reducing the partial pressure of methane gas in the overall gas flow, the concentration of carbon precursors would be low enough to favor the growth of graphene single crystals over nucleation. Third, the deposition parameters can be controlled so the single crystal graphene grains grow to a relatively large size, but not too large to stack over one another. The parameters include chamber pressure, temperature, heating and cooling discipline, deposition time and composition and flow rate of the overall gas flow.

Many investigations indicate the special role of oxygen in the CVD growth of single crystal graphene. Gan *et al.*'s work showed

that by mild oxidation of the copper substrate before reductive annealing, copper nanoparticles of the proper size could be obtained (Fig. 2b).³⁶ The nanoparticles promoted nucleation and growth of large single crystal graphene sheets. In their work, the origin of the oxidation was identified as the trace amount of oxygen in the Ar gas flow or residual oxygen in the CVD chamber. A detailed investigation into the effect of oxygen during the CVD growth of graphene was performed by Hao *et al.* (Fig. 3).⁴⁷ Various concentrations of surface oxygen in copper substrates were realized by purchasing copper foils with different purities, altering the hydrogen pressure during the reductive treatment and exposure to pure oxygen before the CVD growth. The studies showed that the surface oxygen in the copper substrates could decrease the concentration of the copper active sites by passivation, and thus suppress nucleation, favoring the growth of single crystal graphene nanosheets. Magnuson *et al.* offered a new perspective on the role of oxygen and the oxidation process of the copper substrates.⁴⁸ By intentionally oxidizing the copper substrates, a layer of copper oxides was formed, which would decompose during the following annealing and CVD processes and the residual carbon of the substrates would be eliminated. This kind of behavior was referred to as "self-cleaning". There is also an excellent study of the *in situ* observation of the CVD growth of graphene.⁴⁹ However, a deeper understanding of oxygen in the process is still needed to understand the complete role and mechanism of oxygen and to achieve delicate control over the condition of oxygen.

CVD growth of 2D boron nitride (BN)

Group III–V compound thin films have been the focus of artificially-synthesized thin-film materials. Since the 1970s, GaAs thin films have been widely studied *via* molecular beam epitaxy. Other group III–V compounds such as BN have also attracted much interest from the scientific community. For crystalline BN, there are two types of crystallinity, cubic and hexagonal, designated c-BN and h-BN. C-BN exhibits several fascinating properties, with a hardness second only to that of diamond, high thermal conductivity, high chemical stability and a wide bandgap. In the early research into crystalline BN, much effort was focused on c-BN. H-BN is a relatively new type of material, consisting of sp²-bonded hexagons like graphite. H-BN exhibits a high electrical resistivity, high thermal conductivity, extremely low dielectric constant and outstanding lubrication and anti-corrosion properties. It is vital to effectively control the crystallographic phase of the obtained BN films, which could benefit future applications. However, due to the high cost of molecular beam epitaxy BN, CVD is introduced to lower the cost and promote the widespread production. BN is very suitable for CVD growth since the precursors of B and N are mostly gaseous sources.

Pieson's work is among the earliest studies on synthesizing BN *via* CVD.⁵⁰ The deposition was carried out in a vertically set CVD device, using BF₃ and NH₃ as precursors of B and N, respectively. The deposition took place on BN felt fiber substrates at temperatures of 1100 °C to 1200 °C, demonstrating the plausibility of synthesizing BN *via* CVD. However, BN was



Table 1 The influence of CVD growth parameters on the quality of graphene

Precursor	Special pre-deposition treatment of substrates	Substrates	Metal catalyst	Growth condition	Atmosphere & gas flow	Morphology	Properties	Remarks
Camphor	N/A	Ni	Ni	700–850 °C	Atmospheric pressure, Ar	Multi layer graphene film	N/A	Ref. 8
Methane	60 minutes, 40 mTorr, 2 sccm H ₂ , 1000 °C	Cu	Cu	1000 °C, 30 min	~500 mTorr, 2 sccm H ₂ , 35 sccm CH ₄	Single layer graphene films with no more than 5% of domains double or triple layered	Carrier mobility ~ 4050 cm ² V ⁻¹ s ⁻¹	Ref. 18
Methane	900 W nitrogen plasma 40 Torr several min	Si	N/A	Over 1000 °C, 900–1300 W microwave	40 Torr, 10–40% methane in N ₂	Multi layer graphene film	Fast electron-transfer, selective electrocatalysis	Ref. 25
Methane	N/A	Sapphire	N/A	1450–1650 °C, 45 s–5 min	600 Torr, ~10 000 sccm Ar, 5–200 sccm CH ₄ , H ₂ :CH ₄ = 5–15	Single layer graphene films	Carrier mobility ~ 2000 cm ² V ⁻¹ s ⁻¹	Ref. 26
Methane	1180 °C, 30 min, 250 sccm H ₂ , 300 sccm Ar	Various dielectric materials	N/A	1180 °C, 2 h	Atmospheric pressure CH ₄ : H ₂ = 1.9 ~ 2.3 : 50 sccm	Single crystal hexagonal and dodecagonal up to 11 μm	Carrier mobility 5000 cm ² V ⁻¹ s ⁻¹	Ref. 28
Methane	1040 °C, 10 minutes, 700 sccm H ₂	Pt(111)	Pt	1040 °C, 4 h	Atmospheric pressure, 4 sccm CH ₄ , 700 sccm H ₂	Single crystal hexagonal graphene sheets of 1 mm	Carrier mobility 7100 cm ² V ⁻¹ s ⁻¹	Ref. 29
Methane	Chemical polishing, mild oxidation followed by reductive heat treatment	Cu	Cu	1050 °C, up to tens of hours	Atmospheric pressure, 15 sccm 500 ppm CH ₄ diluted in argon, 21 sccm H ₂	Single crystal hexagonal graphene sheets of up to 5.9 mm	N/A	Ref. 36
Polystyrene, evaporated	Mechanical & chemical polishing, followed by reductive heat treatment	Cu	Cu	950–1050 °C, 30–80 min	Atmospheric pressure, 300 sccm overall gas flow of Ar and H ₂ , 0–10 sccm H ₂	Single crystal hexagonal graphene sheets of up to 1.2 mm	Carrier mobility 5000–8000 cm ² V ⁻¹ s ⁻¹	Ref. 39
Pyridine, bubbled	Reductive heat treatment	Cu	Cu	300 °C, 0.5–5 min	Atmospheric pressure, H ₂ : Ar = (150 : 30 100 : 20, 50 : 10) sccm	Single crystal tetragonal graphene sheets	Nitrogen doped, carrier mobility 53.5–72.9 cm ² V ⁻¹ s ⁻¹	Ref. 40
Methane	Reductive heat treatment	Melted Cu on W	Cu	1120 °C, 3–5 min	Atmospheric pressure, CH ₄ : H ₂ = 3–5 : 300 sccm	Single crystal twelve pointed graphene sheets	Carrier mobility 2000–5000 cm ² V ⁻¹ s ⁻¹	Ref. 42
Methane	Melting and resolidifying under reductive atmosphere	Resolidified Cu on W	Cu	1075 °C, 5 h	Atmospheric pressure, CH ₄ : H ₂ : Ar = 46 : 100 : 854 sccm	Single crystal hexagonal graphene sheets of ~1 mm	N/A	Ref. 44
Methane	Reductive heat treatment followed by oxygen exposure	Oxygen-rich Cu	Cu	1035 °C, 30 min	CH ₄ , 5 × 10 ⁻³ Torr H ₂ , 0.1 Torr	Multi-branched graphene domains	Carrier mobility 15 000–30 000 cm ² V ⁻¹ s ⁻¹ at room temperature	Ref. 47

deposited homogeneously on the BN substrates, limiting the applications of CVD BN. For heterogeneous synthesis, Yamaguchi *et al.* demonstrated CVD grown BN on non-BN substrates for the first time.⁵¹ In detail, comparative stoichiometric BN films were grown on InP substrates *via* CVD using B₂H₆ and NH₃ as precursors of B and N, respectively. By introducing PH₃ into the overall gas flow, the doping of BN with P was also realized. P-doped BN films on InP substrates were readily applied as gate

insulation. Similar work by Nakamura *et al.* showed that the composition of the BN films synthesized by CVD could be closely controlled by varying the partial pressures of the respective gaseous precursors.⁵² In addition, various routes of CVD growth to obtain BN were demonstrated, including MOCVD⁵³ with (C₂H₅)₃B and NH₃ gaseous precursors, microwave PECVD⁵⁴ with NaBH₄, NH₃ and H₂ precursors, and single precursor CVD process⁵⁵ with a polymeric cyanoborane



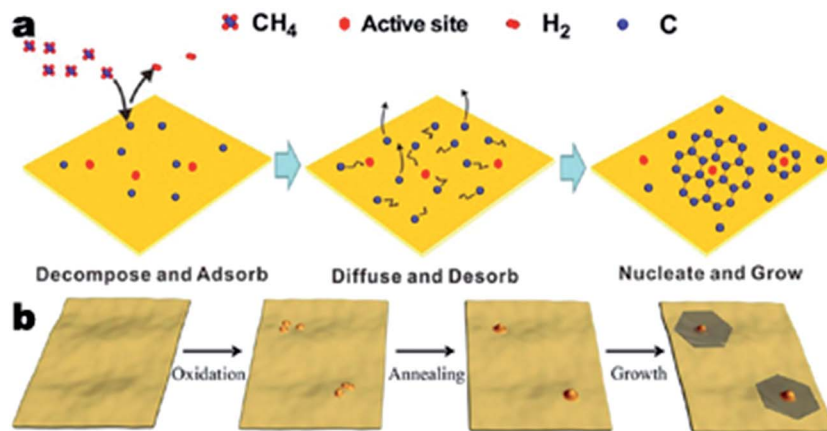


Fig. 2 Schematic illustration for the growth mechanisms of the CVD growth process of graphene. (a) CVD growth process with a methane precursor, reprinted from ref. 35 by permission of American Chemical Society; (b) scheme of the mild oxidation and sequential reductive heat treatment before the CVD process, reprinted from ref. 36 by permission of American Chemical Society.

precursor. These early works on the CVD growth of BN opened up the field and set the foundation for CVD 2D BN nanosheets.

Several works have demonstrated the CVD growth of 2D BN thin films. For example, Shi *et al.* demonstrated CVD growth of h-BN thin films with a thickness of a few to tens of nanometers (Fig. 4a).⁵⁶ In this work, the h-BN thin films were deposited using an APCVD system, in which polycrystalline Ni was exposed to borazine vapor diluted in the N₂ gas flow. By controlling the deposition temperature, a polymerization reaction took place to form polyborazylene, which could be further dehydrogenated to form h-BN with few layers. Similar work by Song *et al.* demonstrated the large-scale CVD growth of high-quality h-BN films consisting of 2 to 5 atomic layers.⁵⁷ Ammonia borane (NH₃-BH₃) was applied as the precursor of BN, and was carried along by a gas flow of Ar/H₂ (15% vol H₂, 85% vol Ar). The deposition was done at a temperature of around 1000 °C with a typical growth time of 30–60 minutes.

Growing single layer BN films on various substrates requires more delicate control over the synthesis parameters, such as precursors, temperatures, content and flow rate of the overall

gas flow, and chamber pressures.⁵⁸ Auwärter *et al.* demonstrated the CVD growth of single layer BN on Ni(111) with B-trichloroborazine as the single precursor.⁵⁹ The deposition process was pretty straightforward, but required a rather sophisticated pre-deposition treatment of the Ni(111) substrates to eliminate irregularities and a delicate control over the overall gas flow due to the sensitive nature of the B-trichloroborazine precursor. Several works also have demonstrated the CVD growth of single layer BN on single crystal transition metal substrates such as Au(111), Ru(001), Rh(111), and Pt(111).^{60–64} These works were carried out *via* ultra high vacuum chemical vapor deposition (UHVCVD). Considering the high growth rate of BN, it is difficult to grow single layer BN films, while UHVCVD could lower the growth rate and favor the growth of single layer BN with a low concentration of precursors. Uniform APCVD or LPCVD growth of single layer BN is also difficult due to the high deposition rate, and the resulting films consist of multiple-layer domains.⁶⁵ For a typical LPCVD growth of single layer BN,⁶⁶ the temperature was 1100 °C under a constant pressure of 0.1 Torr with decomposed ammonia borane

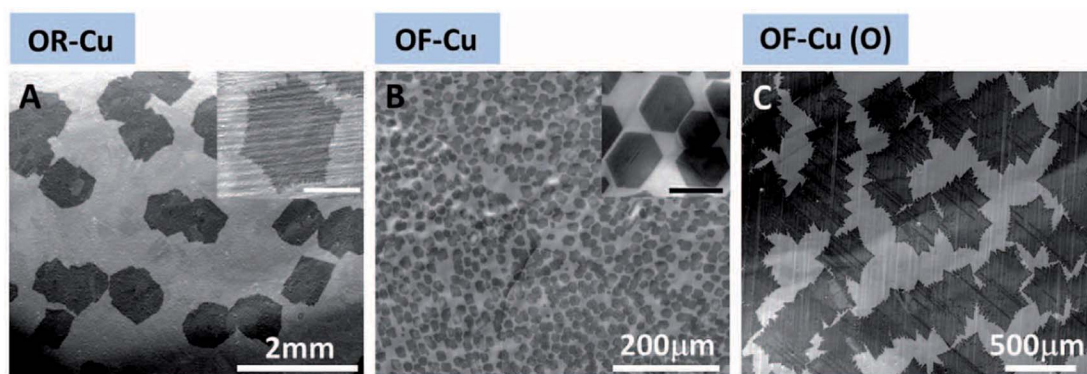


Fig. 3 The effect of O on graphene nucleation density and domain shapes on various types of Cu substrates. OR-Cu (A) represents low-purity copper substrates, OF-Cu (B) represents high-purity copper substrates, and OF-Cu (O) (C) represents high-purity copper substrates exposed to oxygen before the CVD growth of graphene. Reprinted from ref. 47 by permission of American Association for the Advancement of Science.



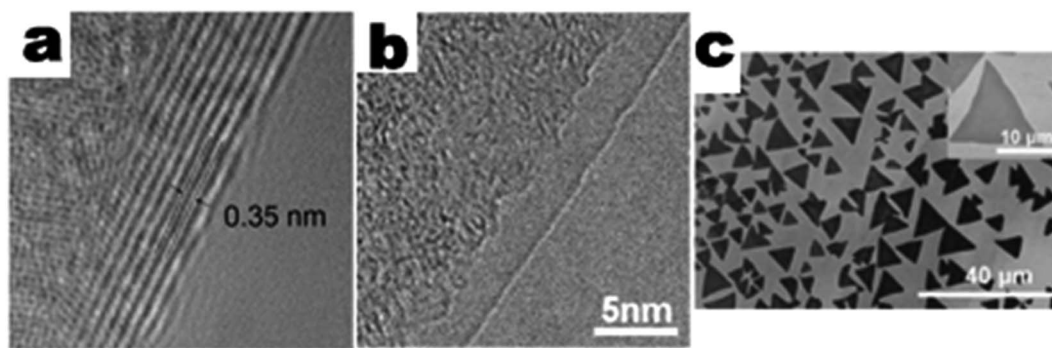


Fig. 4 TEM image of few layer (a) and single layer (b) BN synthesized using CVD, reprinted from ref. 56 (a) and ref. 68 (b) by permission of American Chemical Society; SEM image of CVD synthesized single crystal BN (c), reprinted from ref. 70 by permission of John Wiley & Sons, Inc.

as a gaseous precursor. Kim *et al.* employed an alternative single source to provide precursors.⁶⁷ Borazane powder was decomposed to produce a BN precursor and the deposition was achieved on Cu substrates at a lower temperature under a pressure of 350 mTorr. Based on the understanding of the deposition process, Gao *et al.* developed a new route to gain control over the number of BN layers during APCVD growth.⁶⁸ Park *et al.* demonstrated an LPCVD process that resulted in large-area monolayer BN.⁶⁹ At a pressure of below 0.1 Torr, large-area monolayer BN was obtained using cleaned, annealed Pt as a substrate and borazine bubbled by hydrogen as a precursor.

In the typical APCVD process, vaporized borazane carried by Ar was mixed with an Ar/H₂ mixture to form the overall reactive gas flow, and a filter was introduced upstream of the deposition site to eliminate BN nanoparticles from the thermal decomposition of borazane. By altering the concentration of borazane in the overall gas flow, selective monolayer, bilayer and few-layer BN growth was realized.

Growing single crystal BN nanosheets *via* CVD is still a big challenge and more efforts are obviously required. In one work, Gao *et al.* achieved individual single/double layer BN domains by altering the deposition time and concentration of the precursor (vaporized borazane) (Fig. 4b).⁶⁸ The size of the individual BN domains was around 1 μm, and demonstrated the possibility of obtaining single crystal sheets by controlling the growth process. In another study, Wang *et al.* tried to regulate the nucleation process in the beginning of the CVD growth (Fig. 4c).⁷⁰ The density of nucleation was significantly reduced by thoroughly annealing the Cu substrates under a reductive atmosphere (at 1050 °C for up to 6 hours) with ammonia borane as the precursor. BN single crystal sheets with sizes up to 20 μm were normally observed. Larger grains mean fewer domain boundaries and will lead to better performance in the future application of devices.

CVD growth of 2D transition metal dichalcogenides

TMDs are fundamentally and technologically intriguing due to their unique electronic and optical properties. The behaviors of TMDs are varied, ranging from insulating, semiconducting,

truly metallic to superconducting. Reducing the stacking of TMDs to atomic layers leads to new characteristics induced by quantum confinement effects. Similar to graphene, single- and few-layer 2D TMD nanosheets can be obtained from either top-down routes like mechanical exfoliation or bottom-up processes like chemical vapor deposition (CVD). The aims of the CVD growth of TMDs are to grow few- and single- layer sheets, and to prepare single crystal TMD atomic layers. Atomic layer control offers controlled properties and single crystal atomic layers result in better performance over their polycrystalline counterparts in many device applications.

CVD growth of TMDs dates back to 1988 when Hofmann demonstrated MOCVD growth of MoS₂ and WS₂ on various substrates.⁷¹ In this early work, MoS₂ and WS₂ were grown on various substrates, such as insulators/optical materials (glass, quartz, LiF, MgO and mica), transition metals and noble metals/conductors (Mo, Au, Pt, Al, Cu and steel). The precursors of Mo and W were hexacarbonyls of the corresponding transition metals and the precursor of S was vaporized sulfur or hydrogen sulfide gas. However, the films are normally thick. To prepare two dimensional atomic layers or single layers, several techniques in CVD have been developed. Liu *et al.* reported a two-step thermolysis process,⁷² in which ammonium thiomolybdates [(NH₄)₂MoS₄] were dip-coated onto the substrates, and were converted to MoS₂ by annealing at 500 °C under an Ar/H₂ atmosphere followed by sulfurization at 1000 °C using sulfur vapor along with Ar gas. High-resolution TEM analysis identified that the thickness of MoS₂ is three layers, and the MoS₂ films could be easily transferred onto other arbitrary substrates. The sulfurization process with S vapor drastically enhanced the crystallinity of MoS₂. In another work, few layer TMDs were obtained through conventional CVD processes. Zhan *et al.* reported the CVD growth of large-area MoS₂ few-layer atomic layers based on the sulfurization of Mo metal films (Fig. 5a).⁷³ A thin layer of Mo was deposited on SiO₂ using an electronic beam evaporator before being placed in the tube furnace for CVD growth. Sulfur vapor was introduced into the process by heating the sulfur powder. The size of the grown MoS₂ depended on the size of the substrates, and the thickness of the MoS₂ depended on the thickness of the Mo films deposited on the substrates.



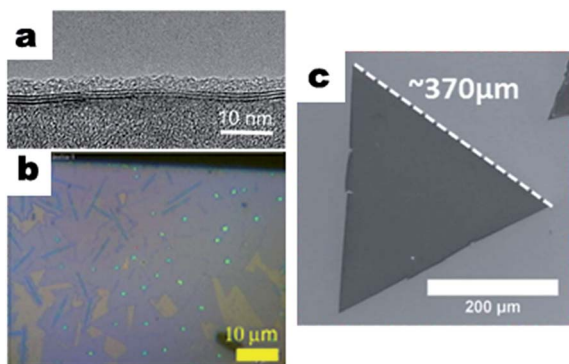


Fig. 5 (a) TEM image of CVD grown few layer MoS₂, reprinted from ref. 73 by permission of John Wiley & Sons; (b) optical microscopy image of CVD synthesized single layer MoS₂, reprinted from ref. 75 by permission of American Chemical Society; (c) SEM image of a CVD synthesized single crystal WS₂ nanosheet, reprinted from ref. 82 by permission of the Royal Society of Chemistry.

Besides elemental precursors, transition metal oxides could also be applied as the precursors. For example, Lee *et al.* synthesized few-layer MoS₂ using CVD.⁷⁴ In this work, MoO₃ was converted to MoS₂ by sulfurization. The pre-deposition treatments of substrates like SiO₂ with aromatic molecules were applied to assist the growth of MoS₂ atomic layers. However, in this work, full coverage of the substrates remained challenging. Liu *et al.* demonstrated a more delicate version of this technique,⁷⁵ where a three-zone tube furnace with a much longer reaction zone and a stable temperature were required and the distance between sulfur and MoO₃ could be adjusted without compromising the temperature zone (Fig. 5b). The as-synthesized MoS₂ exhibited strong capabilities in gas and chemical sensing applications. Najmaei *et al.* modified this route further by hydrothermally synthesizing MoO₃ nanoribbons to act as precursors of Mo.⁷⁶ By altering the number of MoO₃ nanoribbons dispersed onto the substrates, control over the Mo precursors and the resulting atomic layers was realized. McCreary *et al.* grew monolayer MoS₂ films on graphene substrates.⁷⁷ In this study, the precursor for Mo was MoCl₅ which was different from most other works, and MoS₂ films with 1, 2 or 3 layers were obtained by altering the amount of MoCl₅. Huang *et al.* prepared large area monolayer WSe₂ on

sapphire substrates using CVD with WO₃ and Se applied as the corresponding precursors.³⁸ The CVD process was carried out under a mixed gas flow of Ar and H₂, which assisted the activation of the reactions between Se and WO₃. At a relatively low temperature of 750 °C, a continuous monolayer film of WSe₂ was obtained.

CVD growth of single crystal TMDs is still a big challenge to date, and the obtained single crystal TMD flakes or domains achieved so far are relatively small compared to the single crystal graphene flakes. However, some success in the CVD growth of single crystal TMDs with large domain sizes has been realized recently. To grow single crystal TMDs, the main solutions are still to reduce the nucleation density to form larger domains/grains, and to control the growth process to obtain individual domains that form fewer or no domain boundaries. Laskar *et al.* demonstrated the CVD growth of large area single crystal MoS₂ with (0001) orientation,⁷⁸ where single crystal Al₂O₃ was applied as the substrate. The overall CVD process was basically the sulfurization of evaporated Mo thin films using sulfur vapor. By tuning the sulfurization time, high quality MoS₂ films were obtained and were confirmed by planar view selective area diffraction patterns. However, the resulting films were relatively thick hindering further applications.

Besides elemental Mo and S, MoO₃ and S could also be applied as precursors for the CVD growth of single crystal MoS₂. Wang *et al.* demonstrated layer-by-layer sulfurization CVD growth of single crystal MoS₂ flakes.⁷⁹ The process was based on the conversion of MoO₃ to MoS₂ by sulfurization with vaporized S. Some MnO₂ was introduced into the process to react with the excess sulfur. It should also be noted that the substrates were placed downstream of MoO₃ rather than on top of it as in most cases. By controlling the deposition parameters, the layers of the obtained highly oriented MoS₂ flakes could be controllably tuned from single, double, triple to quadruple layers. van der Zande *et al.* prepared monolayer single crystal MoS₂ nanosheets with sizes up to 120 μm *via* CVD growth.⁸⁰ The process was carried out under atmospheric pressure in a N₂ gas flow, and a high yield was obtained with ultra clean substrates and fresh precursors.

This process could be applied to other TMDs as well. Zhang *et al.* demonstrated the CVD growth of monolayer single crystal WS₂ nanosheets on single crystal sapphire substrates using WO₃ and S as precursors.⁸¹ The synthesis process was carried

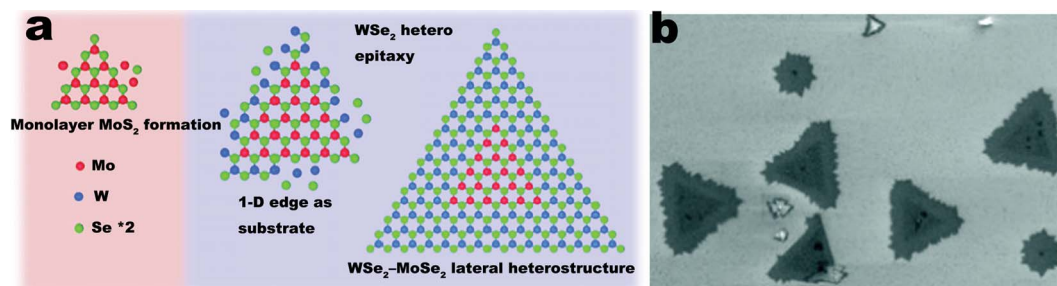


Fig. 6 (a) Schematic illustration of the CVD growth process of WSe₂-MoSe₂ lateral heterostructures; (b) SEM image of WSe₂-MoSe₂ lateral heterostructures. Reprinted from ref. 86 by permission of American Chemical Society.



out under a low pressure at a temperature of ~ 900 °C for ~ 60 minutes and the products were monolayer single crystal WS₂ nanosheets with sizes up to 50 μm . Rong *et al.* demonstrated the CVD growth of large single crystal domains of WS₂ (Fig. 5c).⁸² By controlling the time and amount of sulfur introduced before and during the CVD process, monolayer WS₂ domains with sizes up to 370 μm were obtained, which were visible to naked eye. The pre-deposition treatment of WO₃ with sulfur was realized by heating the sulfur 15 minutes before the WO₃ was heated up to the designated temperature for the CVD process. It should also be noted that, by loading aromatic molecules onto the substrates as seeding promoters, the synthesis of large monolayer single crystal TMDs is favored. For example, Ling *et al.* demonstrated the favored growth of large single crystal TMD monolayers with a substrate loaded with seeding promoters.⁸³

Besides the TMD materials mentioned above, heterostructures based on TMD materials are attracting great interest. First principle calculations of band offsets predicted that certain kinds of TMD monolayer based heterostructures with type-II band alignment would be suitable for applications in the fields of photovoltaics, optoelectronics and energy conversion and storage.⁸⁴ Other than type-II band alignments, heterostructures based on single-layer TMDs and graphene with Schottky barriers were also investigated by theoretical calculations. Bernardi *et al.* have theoretically demonstrated that bilayer solar cells of MoS₂/graphene of 1 nm thickness could achieve over 1% power conversion efficiency.⁸⁵ These theoretical works predicted that bilayers of TMD/TMD or TMD/graphene could be promising in various fields of applications. There are several experimental works on TMD based heterostructures. Huang *et al.* demonstrated lateral heterostructures within single layer MoSe₂-WSe₂ materials.⁸⁶ The synthesis process was the vaporization and deposition of a mixture of MoSe₂ and WSe₂ with high purity H₂ working as a carrier gas (Fig. 6). Duan *et al.* developed a CVD system that allowed the *in situ* switch of solid sources.⁸⁷ By sequentially vaporizing and depositing WS₂ and WSe₂, WS₂-WSe₂ lateral heterostructures were obtained under high temperature, atmospheric pressure and vigorous Ar flow. Furthermore, Duan *et al.* also demonstrated the synthesis of single to few layer MoS₂-MoSe₂ lateral heterostructures using the same system. MoO₃ was applied as precursor of Mo, when S and Se powders were sequentially vaporized and reacted with MoO₃ to obtain MoS₂-MoSe₂ lateral heterostructures. Similarly, Zhang *et al.* demonstrated the CVD synthesis of TMD lateral heterostructures by the sequential CVD synthesis of the corresponding TMDs.⁸⁸

Conclusion and perspective

We have briefly reviewed the CVD growth of two-dimensional materials, focusing on three types of signature 2D materials, graphene, BN and TMDs. The preparation processes and fundamental growth mechanisms of CVD growth, from few and single layer films to single crystal atomic sheets, are discussed. Substantial progress has been made in understanding the

influence of the growth parameters, including precursors, substrates, atmospheres and gas flows.

The development in the CVD growth of 2D materials is driven by the growing demand for high quality 2D materials in various fields of applications where full control of CVD growth is critical. However, such full control over the CVD growth process is still yet to be achieved. Complete understanding of the impact of the growth parameters has a special importance for realizing the programmable control of CVD growth and the high quality of grown 2D materials. For example, the synthesis of larger single crystal 2D materials with a quality comparable to those produced by mechanical exfoliation is still a big challenge. As for the CVD process, the key factors for larger single crystal 2D materials are the suppression of nucleation and well-maintained growth. Suppression of nucleation could be realized by thoroughly cleaning and smoothing the substrates, lowering the concentration of the precursors, and carrying out the process at a higher temperature. Well-maintained growth processes could be achieved by an optimized temperature, pressure and gas flow where slow growth may need a longer growth time than usual growth. In addition to the larger single crystal 2D materials, controllable CVD growth of heterostructures based on 2D materials and integration of the CVD growth of 2D materials with device fabrication are highly expected in the near future.

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